

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10580456	YASUDA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Haidung D Nguyen	1796

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
252	182.11	10/22/08	\HN\

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
inventor search in eDan and Palm	10/24/08	\HN\

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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